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Characterization and reduction of the amplitude-to-phase conversion effects in telemetry

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Abstract: We are developing a telemeter based on the measurement of the phase accumulated by a RF sine wave during its propagation in air. This wave is carried by a laser beam thanks to an intensity modulation. The main limitation of this technique lies in amplitude-to-phase conversion occurring in the detection of this modulation. Therefore, we characterized in this paper this phenomenon for a given telemetric system and discuss on how to reduce its effects on the resolution and the accuracy of the distance measurement. Finally, a solution is implemented and tested outdoor, in real conditions of use.

Introduction

A well-known technique for measuring distances consists in measuring the phase shift accumulated by an intensity-modulated light beam during its propagation in air [1]. This principle is widely implemented, for instance in distance meters for geodetic applications [2] or in absolute trackers for tridimensional measurements in large volumes [3]. We are developing such a telemeter by using common and affordable optoelectronic devices from the telecommunication industry, such as a laser diode at a wavelength of 1550 nm and an EAM (Electro-Absorption Modulator) that enables high modulation frequency, up to 10 GHz in a simple manner. Thus, the light is intensity modulated by a high RF (Radio Frequency) carrier, propagated in air, and then converted by a photodetector into an electrical signal. The phase accumulated by the sine wave during its propagation is measured from this electrical signal after a frequency down-conversion. This down-conversion can be implemented either in the electrical domain using a classical RF mixer, or in the optical domain [4] using a superheterodyne detection [5-7] or a similar MSTAR (Modulation Sideband Technology for Absolute Ranging) technique [8]. In the latter, extra AOMs (Acousto-Optic Modulator) are used to realize the optical demodulation, which implies a more complex and expensive system. Consequently, we choose the option of a direct photodetection at high frequency with a down-conversion based on a RF mixer. This choice allows us to use off-the-shelf components. Nevertheless, this detection at high frequency exhibits important AM/PM (Amplitude Modulation to Phase Modulation) conversions as soon as the optical power varies [9]. In other words, the photodetection becomes a critical part of the system that worsens the phase noise due to AM/PM coupling.

In this paper, we quantified these AM/PM conversions for three different photodiode technologies in order to identify the optimal conditions for noise rejection in distance measurements. This is essential when the power variations of the detected light beam are

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where c is the speed of light in vacuum, n the group refractive index of air (fixed to unity in this paper), f_{RF} the high frequency modulation, and k an integer number corresponding to the number of synthetic wavelengths Λ within the distance to be measured. The latter could be determined by a set of measurement at different RF carriers.

The distance resolution is a function of the chosen synthetic wavelength: the higher the modulation frequency, the better the resolution. However, since high frequency signals cannot be directly measured by the phasemeter – based on a FPGA (Field-Programmable Gate Array) and 245 MSa/s ADCs (Analog to Digital Converters) – a down-conversion at an IF (Intermediate Frequency) of 10 MHz has been implemented before the phase shift measurement. We take advantage of this down-conversion to perform RF amplification at IF and so to be less sensitive to the AM/PM conversions occurring in the electronic stages.

In the phasemeter, a capture of the signals, their digital down-conversions and the calculation of their phase difference are realized every 4 ms. The results are then averaged under Matlab[®] by block of 50 samples (50 x 4 ms) to provide the phase shift measurement. In this configuration and with a RF carrier at 1310 MHz, the whole telemeter provides a resolution – standard deviation over 100 successive phase shift measurements – of 4 μm ($\sim 1/60000$ of the synthetic wavelength).

The phasemeter provides also the amplitude of all the signals used for the phase shift measurements. Thus, from the first measurements, we observed a strong correlation between the amplitude variations (recorded at 10 MHz) of the photodetected signal after propagation in air and the phase shift variations.

Study of the AM/PM coupling

1. Characterization of the AM/PM coupling

We have measured the AM/PM coupling ($\Delta\Phi_{AM/PM}$) occurring in the reception sub-system of our telemeter for three different kinds of free-space InGaAs (Indium Gallium Arsenide) photodetectors – a MSM (Metal-Semiconductor-Metal), an avalanche and a Schottky photodiodes – followed by an electronic stage composed of a mixer, amplifiers and the home-made phasemeter. Table 1 summarizes the characteristics of the tested photodiodes.

Table 1: Characteristics of the tested photodiodes.

	InGaAs MSM photodiode	InGaAs avalanche photodiode	InGaAs Schottky photodiode
Model	Hamamatsu G7096-03	Hamamatsu G8931-04	New Focus 1417
Active Area	200x200 μm^2	40 μm diameter	25 μm diameter
Bias Voltage	up to 15 V	up to 40 V	fixed to 9 V
Wavelength range	[850 - 1650] nm	[950 - 1700] nm	[950 - 1650] nm
RF Bandwidth	rise / fall times of 40 / 120 ps	4 GHz	25 GHz
Efficiency	0.4 A/W @ 1310 nm	0.9 A/W @ 1550 nm	-

The characterization of the reception sub-system was realized using the setup depicted in Fig. 2. We have used the same laser diode and the same optical modulator as the ones described above, and we have added a fibered AOM, used as an optical attenuator, to simulate an amplitude noise. In fact, the power driving the AOM at 80 MHz was square-wave modulated, at low-frequency (200 mHz), to produce sudden optical power changes (AM generation). Thus, we could observe the phase shift variations (PM record) induced by the photodetector and the reception electronic stage. The optical power received by the photodetector can be written as followed:

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$$P_{opt\,total} = \underbrace{\alpha_{AOM}(t)}_{\text{squarewave modulated}} \times G_{EDFA} \times (P_{opt\,DC} + P_{opt\,RF} \cdot \cos(2\pi f_m t + \phi_0)) \quad (3)$$

where α_{AOM} is the optical attenuation induced by the AOM (a function of the power of the 80 MHz carrier driving it), G_{EDFA} is the EDFA gain, $P_{opt\,DC}$ is the average optical power at the EDFA input, $P_{opt\,RF}$ is the RF optical power at the EDFA input, and ϕ_0 is the phase at $t = 0$.

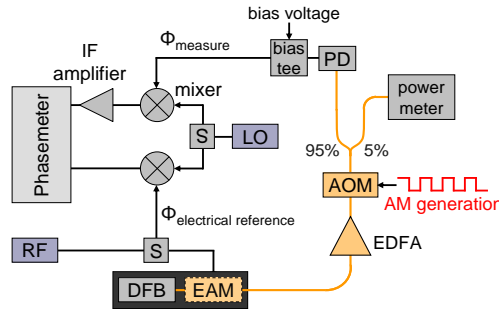


Figure 2: Setup used to characterize the AM/PM coupling occurring in the reception system.

The phase shift variations were recorded as a function of the bias voltage for different optical powers received by the photodiode (by adjusting the EDFA gain). For each record, the same square wave was applied to the AOM: the optical intensity alternated between a maximum and a minimum (24% lower), resulting in a power ratio of $\Delta P = 1.2$ dB. At the photodiode output, the measured RF hops were, as expected, twice bigger due to square law detection.

The results have been normalized by the power ratio ΔP [9] and plotted in Fig. 3. Additionally, we have converted for convenience the phase shift variations $\Delta\phi_{AM/PM}$ into equivalent distance variations $\Delta d_{AM/PM}$ by the following relation:

$$\Delta d_{AM/PM} = \Delta\phi_{AM/PM} \times \frac{c}{2\pi \cdot f_{RF}} \quad (4)$$

Fig. 3 presents the results for the MSM (a) and avalanche (b) photodiodes. The maximum optical power incident onto the avalanche photodiode is lower than the maximum power received by the MSM photodiode (60 μW versus 250 μW) to take into account its higher efficiency and avoiding in this way the saturation of the electronic stage.

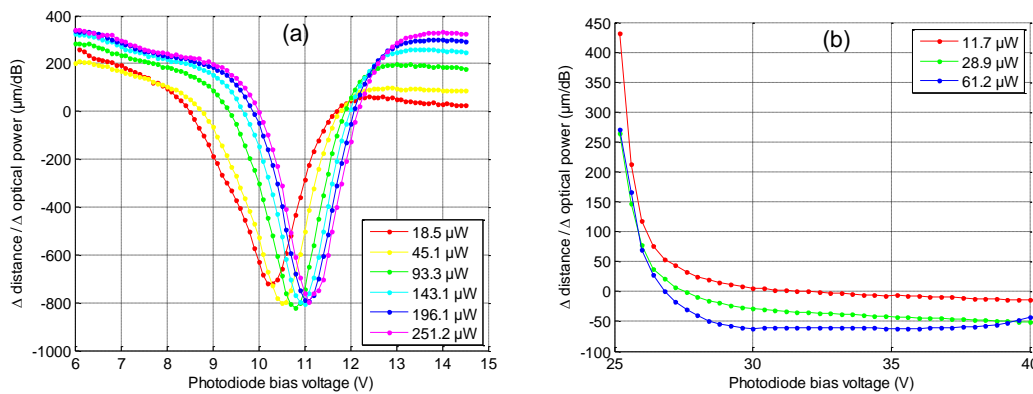


Figure 3: Phase shift variations, converted into distances, as a function of the photodiode bias voltage and for different optical powers incident onto the photodiode. The optical power values indicated in the legends correspond to the maximum values of the square optical power function. (a) MSM photodiode and (b) avalanche photodiode.

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Measurements performed on the MSM photodetector at several days intervals show a good reproducibility of the curve shape, showing two zeros. However, the bias voltages corresponding to these zeros were different from one measurement to another; this is probably due to temperature evolution in the optoelectronic components. Nonetheless for any optical power we always obtained the same curve progression with two null AM/PM coupling values. The avalanche photodiode have shown a different behaviour: the AM/PM coupling curve crosses only once the zero y-axis, but beyond 30V, it remains relatively flat. The results for the Schottky photodiode are presented in Fig. 4 (a). As the bias voltage applied to this photodiode cannot be varied due to its packaging (value fixed by the manufacturer at 9 V), the distance variations have been measured only as a function of the received optical power. The results showed that the AM/PM conversion can be minimized by adjusting the incident optical power at around 100 μW .

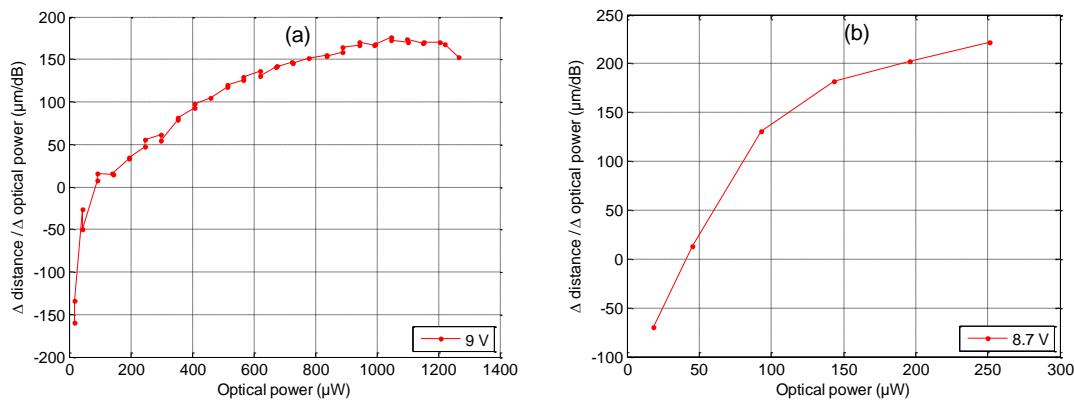


Figure 4: Distance variations as a function of the optical power incident on the photodiode for a fixed photodiode bias voltage. The optical value indicated in the x-axis corresponds to the maximum value of the square optical power function. (a) Schottky photodiode and (b) MSM photodiode.

As shown in Fig. 4 (b), a similar curve is obtained with the MSM photodiode for a bias voltage of 8.7 V. This result is as expected since a MSM structure consists in two metal-semiconductor contacts (Schottky junction) connected back-to-back.

2. Distinction between the AM/PM coupling due to $P_{opt. DC}$ and the one due to $P_{opt. RF}$.

For a better understanding of the phenomenon that occurs in the reception chain, we have separated the effect of the average optical power ($P_{opt. DC}$ in Eq. 3) from the effect of the RF optical signal ($P_{opt. RF}$). To this end, one of these parameters (either $P_{opt. DC}$ or $P_{opt. RF}$) was square-wave modulated (AM generation) while the second one was maintained constant (no AM). This has been realized introducing a second laser in the initial setup of Fig. 2.

2.1 Variation of the average optical power

A sudden optical power change was applied only on the average optical power and not on the RF modulation of the light (refer to Eq. 2). For this purpose, as shown in Fig. 5, the light from the first laser was RF modulated while the light from the second laser was low-frequency square-wave modulated. Thanks to a 50/50 optical coupler, the photodiode received the sum of the two signals as described in Eq. 5 (for clarity coupler insertion losses have been ignored).

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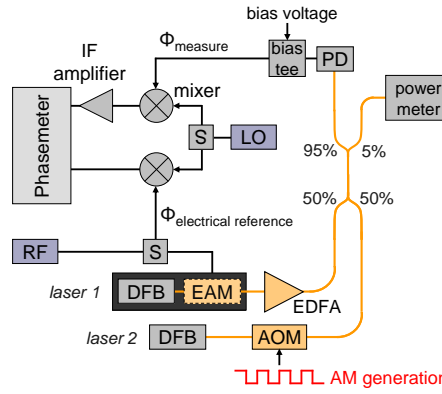


Figure 5: Setup characterizing the AM/PM coupling due to the DC optical power variations only.

$$P_{opttotal} = \underbrace{\alpha_{AOM}(t)}_{\text{squarewave modulated}} P_{optlaser2DC} + G_{EDFA} \times (P_{optlaser1DC} + P_{optlaser1RF} \cdot \cos(2\pi f_m t + \phi_0)) \quad (5)$$

The results are presented in Fig. 6 for the MSM photodiode (a) and the avalanche photodiode (b). The shapes of these curves are similar to the previous ones in Fig. 3. Therefore, it can be concluded that the dependence of the AM/PM coupling on the bias voltage essentially comes from the photodiode, and not from the electronic stages (even if varying the photodiode bias voltage modifies the photodiode efficiency and so changes the received RF power).

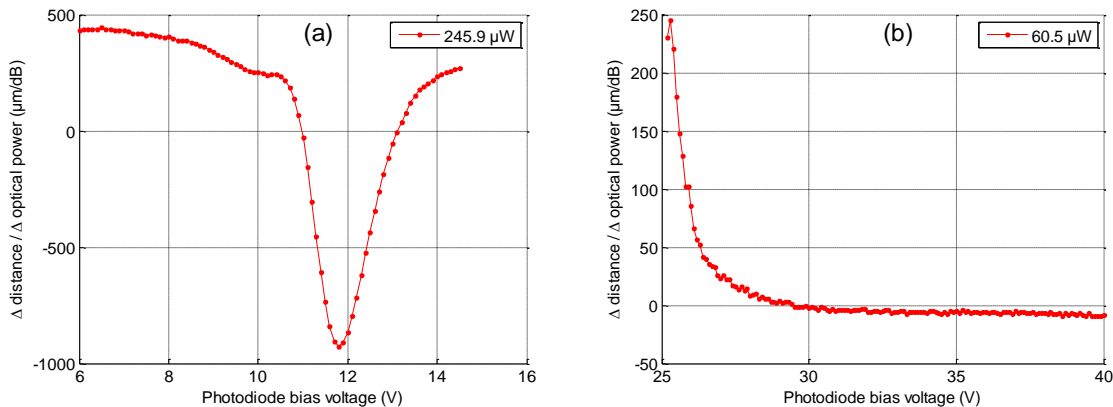


Figure 6: Distance variations as a function of the photodiode bias voltage for a constant RF optical power and a square-wave modulated DC optical power. (a) MSM photodiode in (a) and (b) avalanche photodiode.

2.2 Variation of the RF optical power

The reception system was then studied when only the RF modulation of the light varies. To achieve this, the setup of Fig. 7 has been realized. The arm of the first laser corresponds to the configuration depicted in Fig. 2. Thus, the average and RF optical signals are both modulated (Eq. 3). To maintain a constant average optical signal, a variable optical attenuator (ATT in Fig. 7) was placed on the second arm to counteract the square-wave modulation of the first arm. Thus, the RF power received by the photodiode and the electronic stages varies while the average optical power received by the photodiode is maintained constant.

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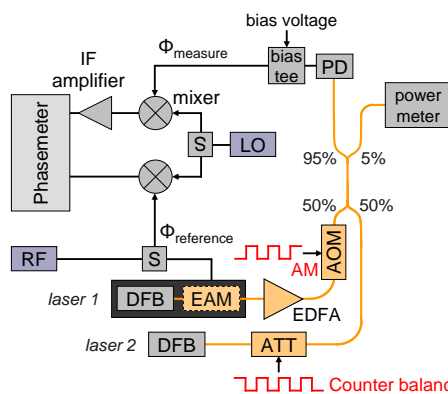


Figure 7: Setup characterizing the AM/PM coupling due to the RF optical power variations only.

The results are presented in Fig. 8. The sudden optical power changes affect only the RF modulation of the light. As a consequence, the results have been normalized by twice the electrical power ratio, which is equivalent to the previous approach.

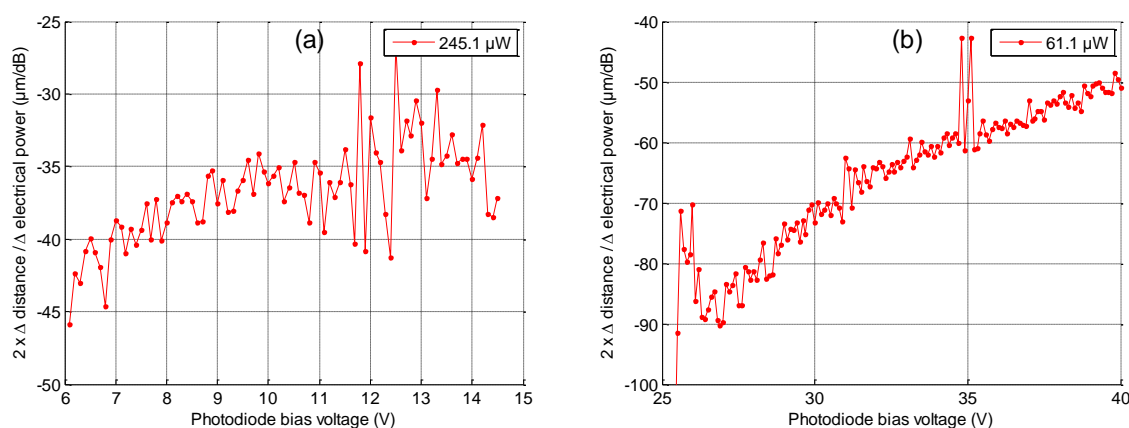


Figure 8: Distance variations as a function of the photodiode bias voltage and for a constant average optical power and a square-wave modulated RF optical power. (a) MSM photodiode and (b) avalanche photodiode.

It appears that the AM/PM coupling depends only weakly on the photodiode bias voltage. As shown in Fig. 8 (a), for the MSM photodiode, a small deviation of only 10 μm is observed. This is probably induced by the electronic stages as the RF power at the photodiode output varies by 3 dB between 6 and 14.5 V due to a change of the photodiode efficiency with the bias voltage. This effect can also be observed in the case of the avalanche photodiode (Fig. 8 (b)) and is more important because the change of the photodiode efficiency is larger: 10 dB from 27 to 40 V.

2.3 Discussion

The AM/PM conversion is not attributed only to the photodiodes, but also to the electronic stage (down-conversion and RF amplification). By adding the contribution of the photodiode (RF power constant and variations of the average optical power) to the contribution of the electronic stage only, we obtain exactly the global contribution of the reception stage to AM/PM coupling (see Fig. 9).

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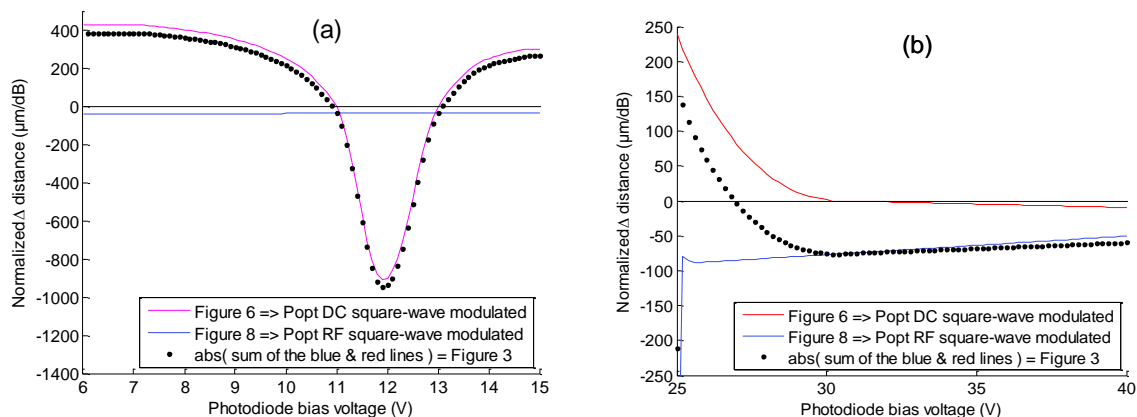


Figure 9: Summary of AM/PM conversions into the photodetectors (red lines), into the electronic stages (blue lines) and into the whole system (black dots). (a) MSM photodiode and (b) avalanche photodiode.

The MSM photodiode exhibits two bias voltages for which the AM/PM coupling is null. However, these values depend on the received optical power, and worse, they are not stable in time. Nevertheless, for bias voltages higher than 13 V (high photodiode efficiency) and low optical power (20 μW), the whole AM/PM conversion becomes acceptable.

The avalanche photodiode shows a weaker dependence of the AM/PM coupling with the bias voltage. Indeed, for bias voltages higher than 30 V the avalanche photodiode itself has an acceptable AM/PM conversion (below 10 $\mu\text{m}/\text{dB}$ for 1.3 GHz of modulation frequency). In that case, the major part of the AM/PM conversion is induced by the electronic stages (the RF mixer and/or the amplifiers).

In both MSM and avalanche photodiodes, we did not find a stable configuration where the AM/PM can be cancelled out. Nevertheless, an appropriate data processing enables to limit the impact of this phenomenon on the resolution of the developed telemeter.

Overcome the AM/PM coupling issue in telemetry application

The digital electronic designed for phase measurements provides the amplitude of input signals additionally to the phase information. Therefore, we can select the phase shift values corresponding to a given amplitude. This approach has been tested for the MSM photodiode. In practice – as our measurement consists in a phase difference between a reference path and the measured path (Fig. 1) – we adjust the amplitude of the reference path signal (with a variable optical attenuator) to the mean value of the measurement path signal. This ensures that measurement and reference signals have the same AM/PM conversion, and so that the system provides a good accuracy.

This approach has been tested over 110 m outdoor along an asphalt road, during a warm (temperature around 35 $^{\circ}\text{C}$) and sunny day, which implies strong air turbulences. As shown in Fig. 10 (in blue), large power fluctuations were observed with some signal cancellations (75% of the measured power was contained within 15 dB). Nevertheless the signal amplitude remained stable over a couple of ms. In these conditions, the standard deviation on the measured distances (i.e. the resolution) was 1.5 mm. However, after filtering the data – only phase values corresponding to amplitudes equal to 7.9 dB \pm 2 dB (in red) was retained – the standard deviation over the measured distances was improved to 38 μm . This corresponds to 27% of the recorded data. By comparison, in ideal conditions, i.e. indoor measurement over 1m, power fluctuations are within 0.1 dB and a standard deviation less than 5 μm was obtained.

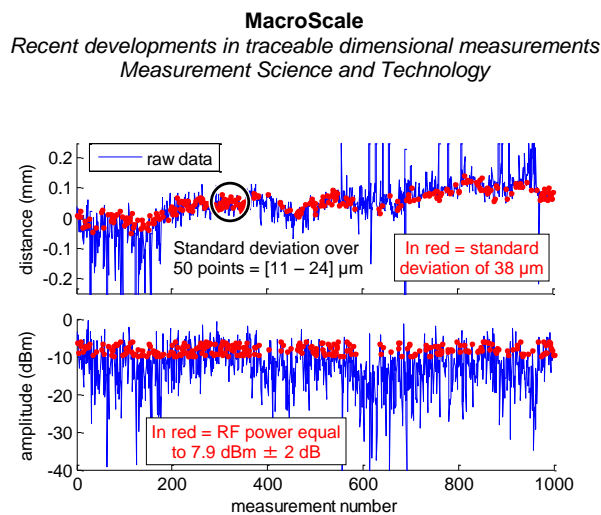


Figure 10: Distance variations and corresponding signal amplitudes of the received signal for 1000 successive distance measurements, which correspond approximately to 1000s. In blue raw data and in red data corresponding to a given RF power ± 2 dB.

In Fig. 10, a drift of 150 μm on the measured distance can be observed. Even if we did not carry out air temperature measurement all along the optical path, this drift can be explained by an average temperature change of 1°C. Indeed, such a change should modify the air refractive index, and consequently the measured distance, by a factor 10^{-6} [12].

It is therefore more relevant to consider the standard deviation at short term (50 s) to ignore the long term drift: thus, we obtain a standard deviation comprised between 11 and 24 μm .

Conclusion

A small intensity noise on a RF modulated optical signal can induce an important phase noise on the RF modulation due to AM/PM conversions that occur in the photodiodes and the electronic stages. The atmospheric perturbations – which involve amplitude changes in the detected intensity-modulated beam – induce unacceptable distance variations in an accumulated-phase-shift based telemeter. We have shown for three photodetector types (MSM, avalanche and Schottky photodiodes) that two parameters are of great importance on the AM/PM conversions: the optical power received by the photodiode and the bias voltage applied to it. Thus, it is possible to find an optical power / bias voltage pair that cancels out the AM/PM coupling. Nevertheless, the photodiode bias voltage corresponding to this cancellation was not enough stable in time. So, in order to minimize this effect raw data were instead filtered to keep only the phase measurements corresponding to the same signal amplitude (the amplitude of the measurement path) within a given interval. This is possible because our digital electronic is able to capture the signals and to process them fastly (within 4 ms), at a time scale where the signal level remains stable. Using this technique, we measured outdoor, with strong turbulences, a distance of 110 m with a short term (50 s) standard deviation better than 24 μm .

These very encouraging results are a first step towards a two-wavelength approach. The simultaneous use of visible and infrared lights in the telemeter will compensate the fluctuations of the air refractive index with temperature taking advantage of dispersion of air index [13].

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